

Powering of Detector Systems

Satish Dhawan, Yale University
Richard Sumner , CMCAMAC LLC



AWLC 2014, Fermilab
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Agenda

Prior / Current Status

- LDO Powering Efficiency

- Buck Converter

- Frequency limited by FeCo

- Commercial Devices limited by 200 KHz – 4 MHz - Core losses

Higher Frequency > smaller components

Wireless Charging, Intel 4th Generation Core

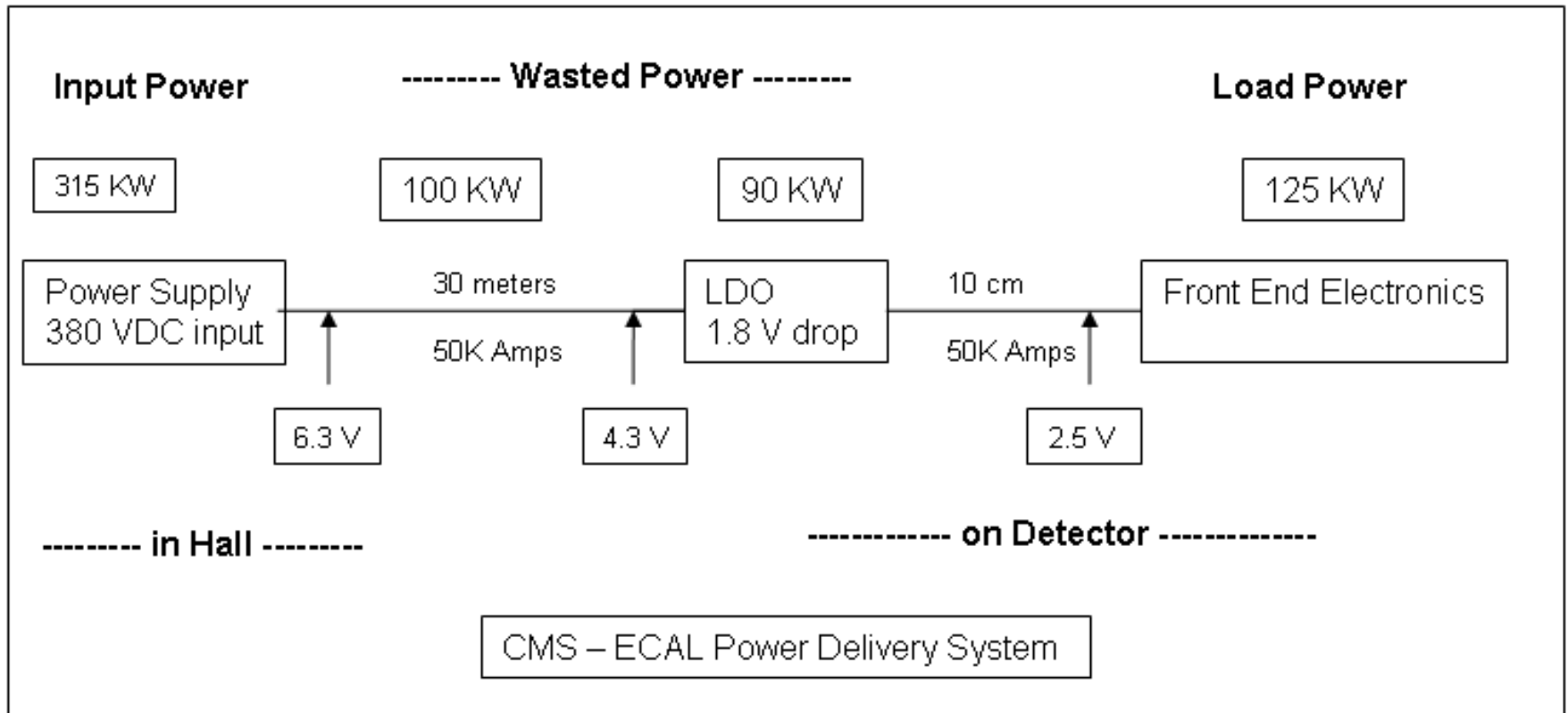
Air Core Toroid vs Planar (spirals). PC Traces @ > 100 MHz

Shielding Electrostatic & RF

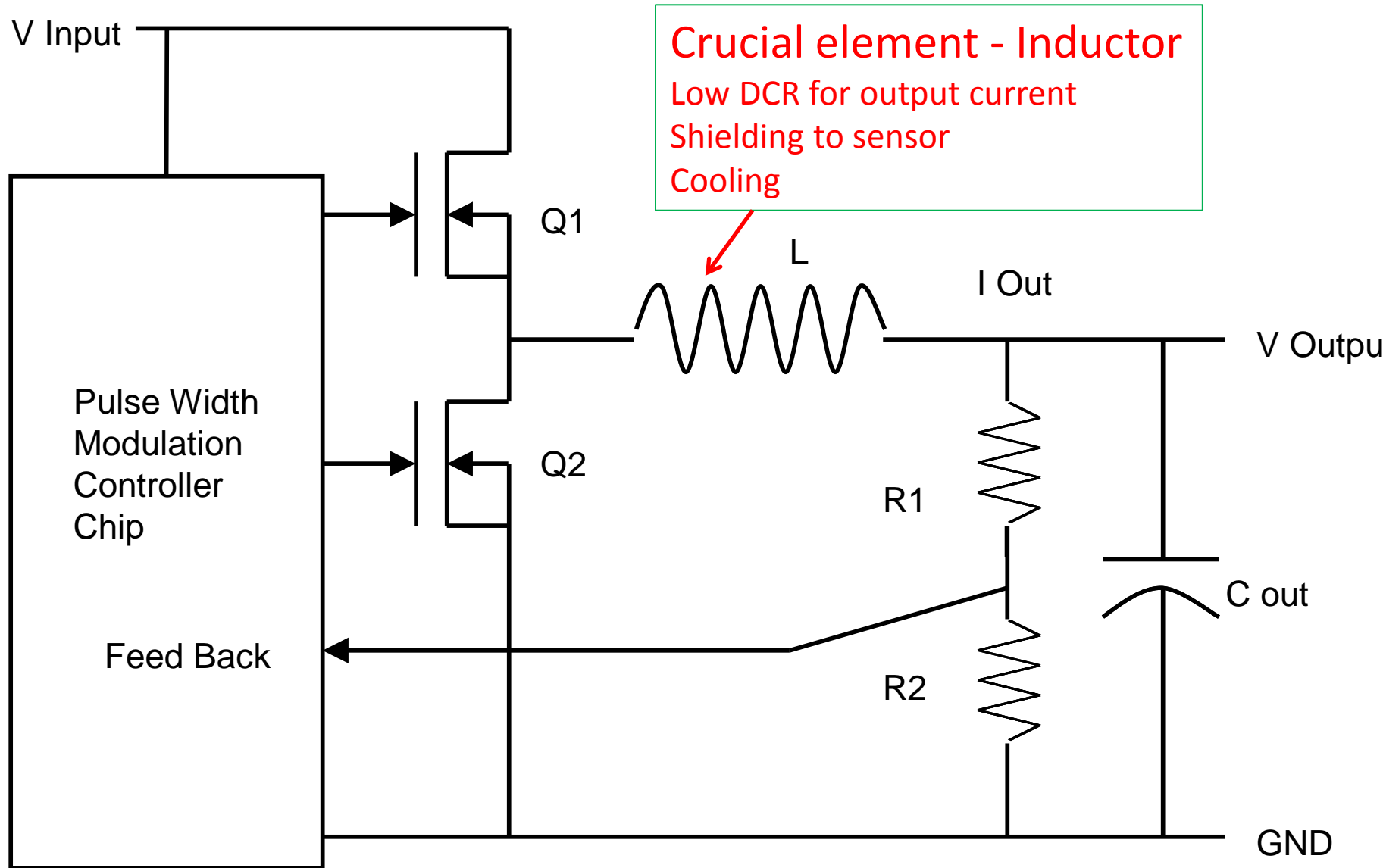
ATLAS Tracker

Future

Power Efficiency _ Inefficiency _ Wasted Power



Power delivery Efficiency = 30 %
with Power for Heat Removal = 20 %

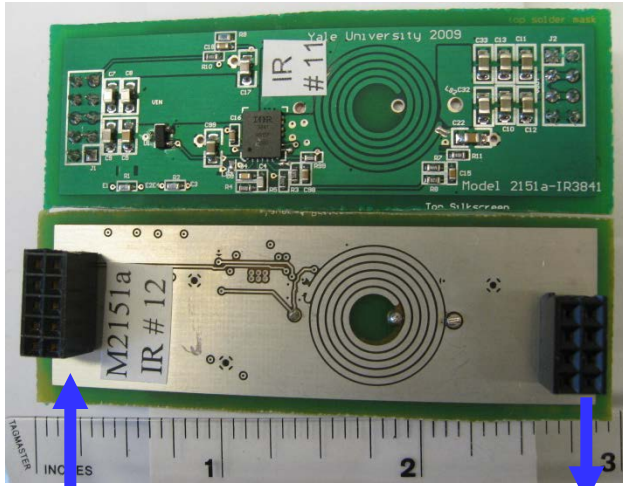


Crucial element - Inductor
 Low DCR for output current
 Shielding to sensor
 Cooling

Fig SR

Synchronous Rectification

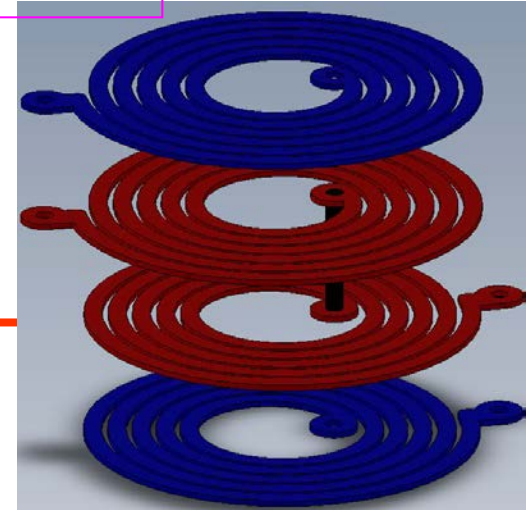
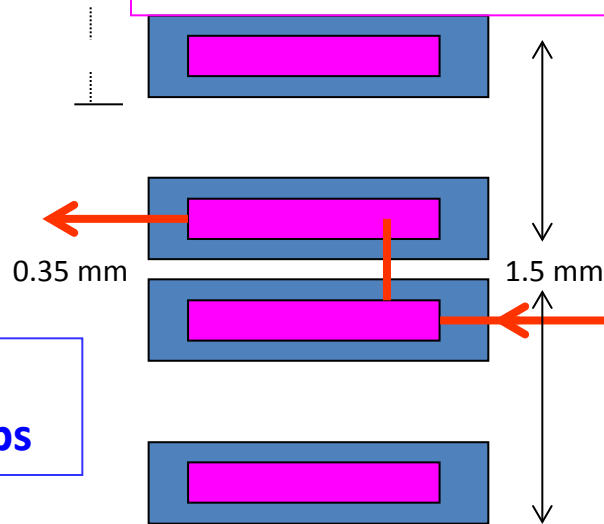
Plug In Card with Shielded Buck Inductor



12 V

2.5 V
@ 6 amps

Coupled Air Core Inductor
Connected in Series



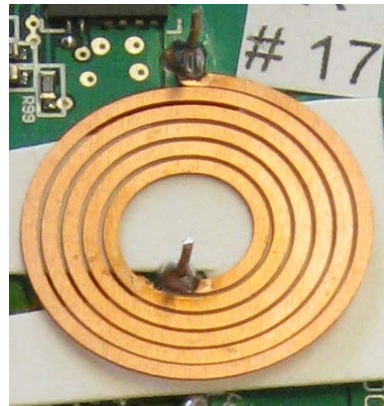
Different Versions

❖ Converter Chips

Max8654 monolithic
IR8341 3 die MCM

❖ Coils

Embedded 3oz cu
Solenoid 15 mΩ
Spiral Etched 0.25mm

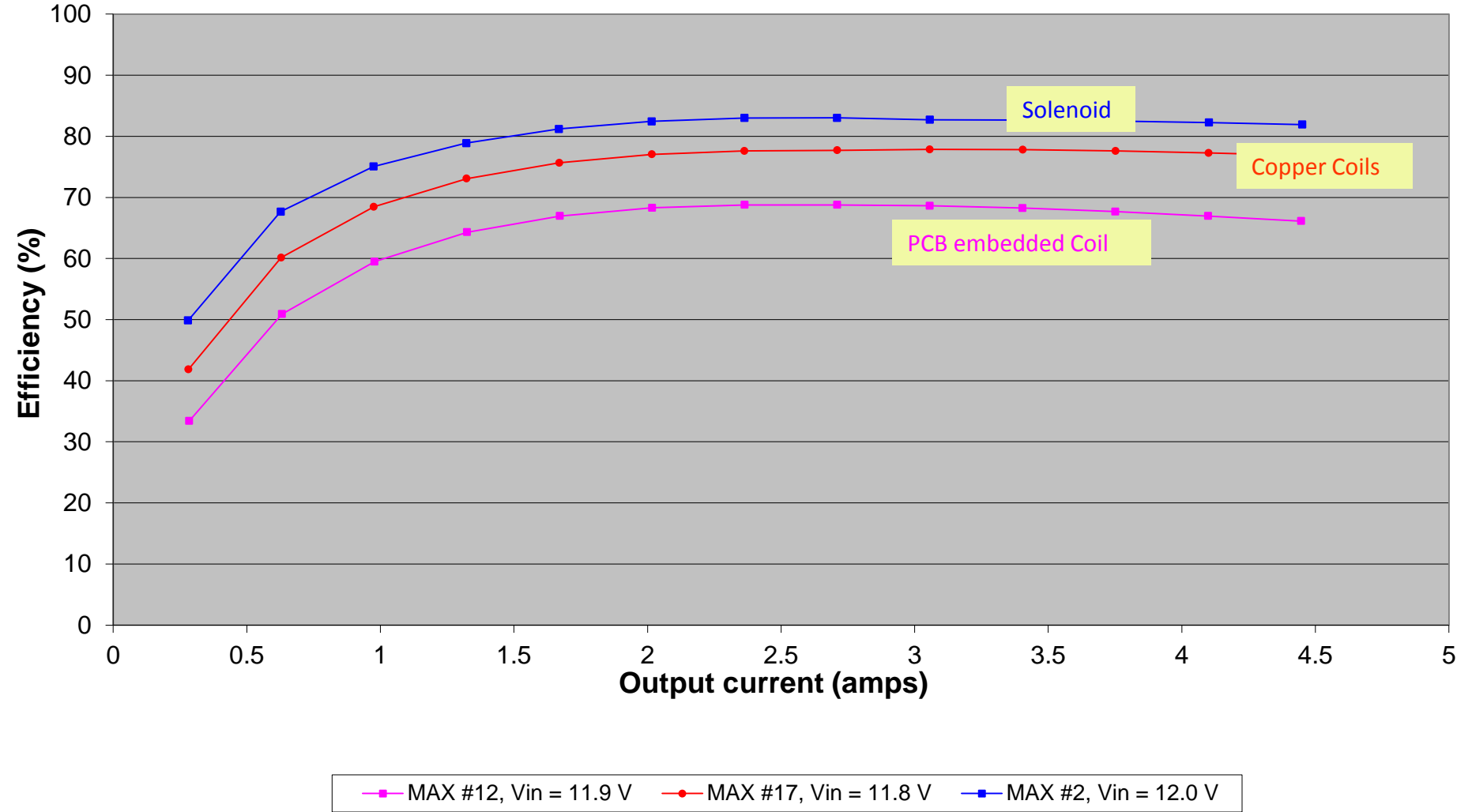


Spiral Coils Resistance in mΩ

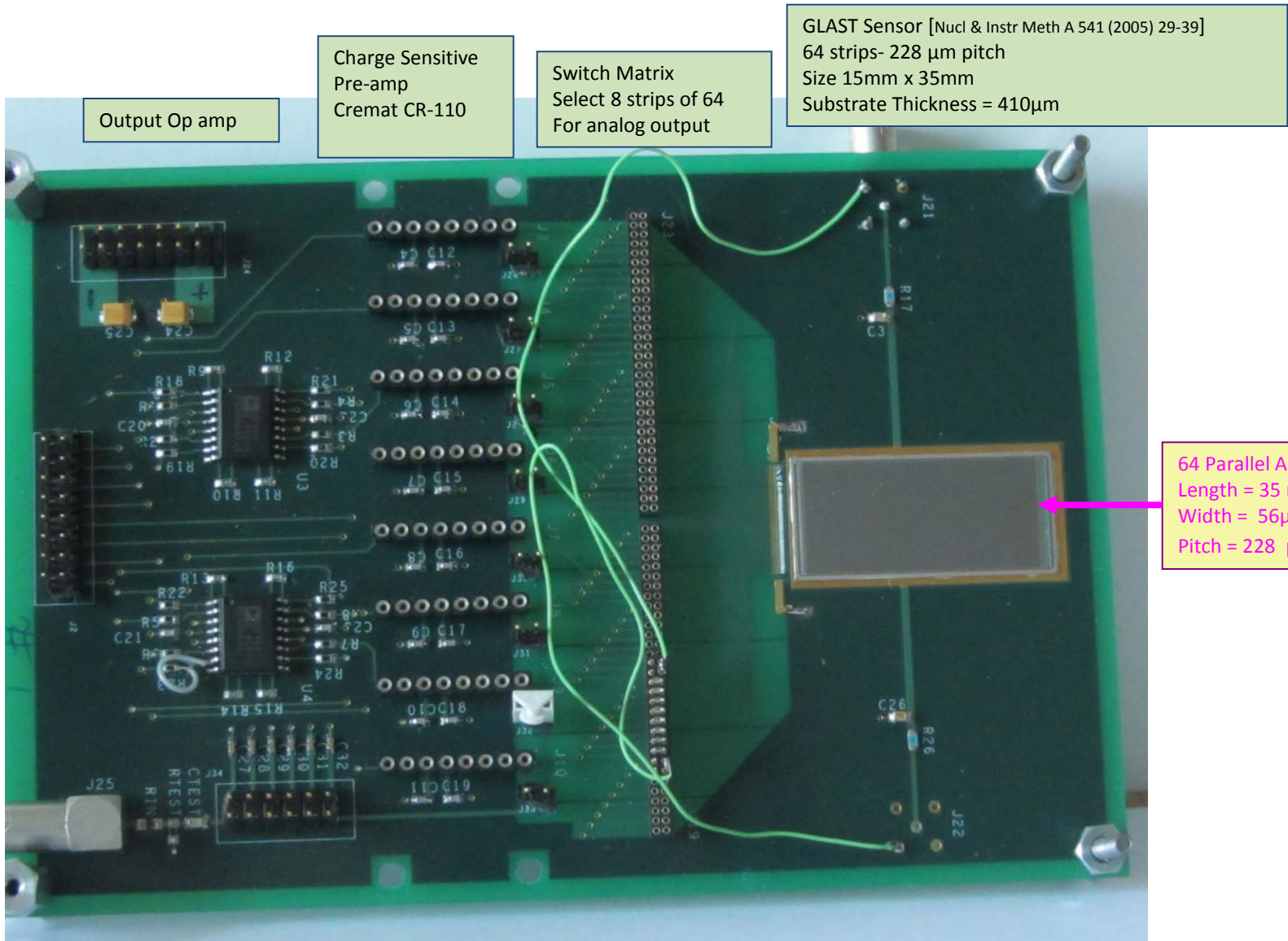
| | Top | Bottom |
|-----------------|------|--------|
| 3 Oz PCB | 57 | 46 |
| 0.25 mm Cu Foil | 19.4 | 17 |

Noise Tests Done: sLHC SiT prototype, 20 μm AL Shield

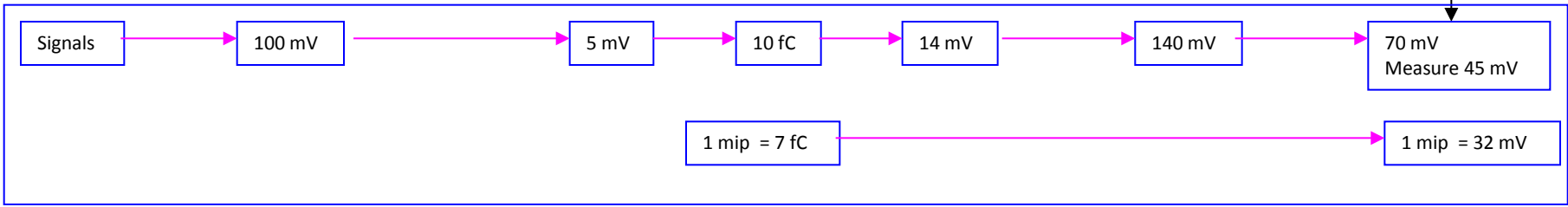
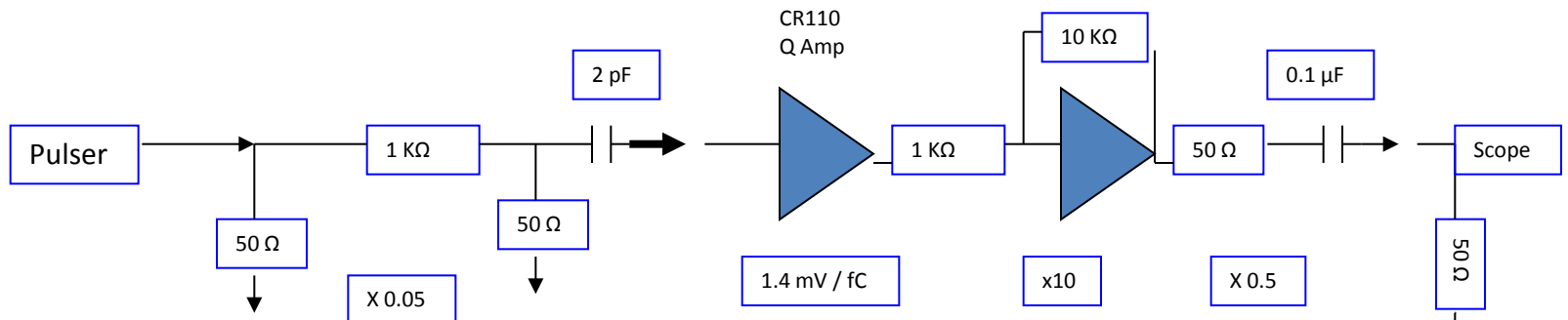
**MAX8654 with embedded coils (#12), external coils (#17) or Renco Solenoid (#2)
V_{out}=2.5 V**

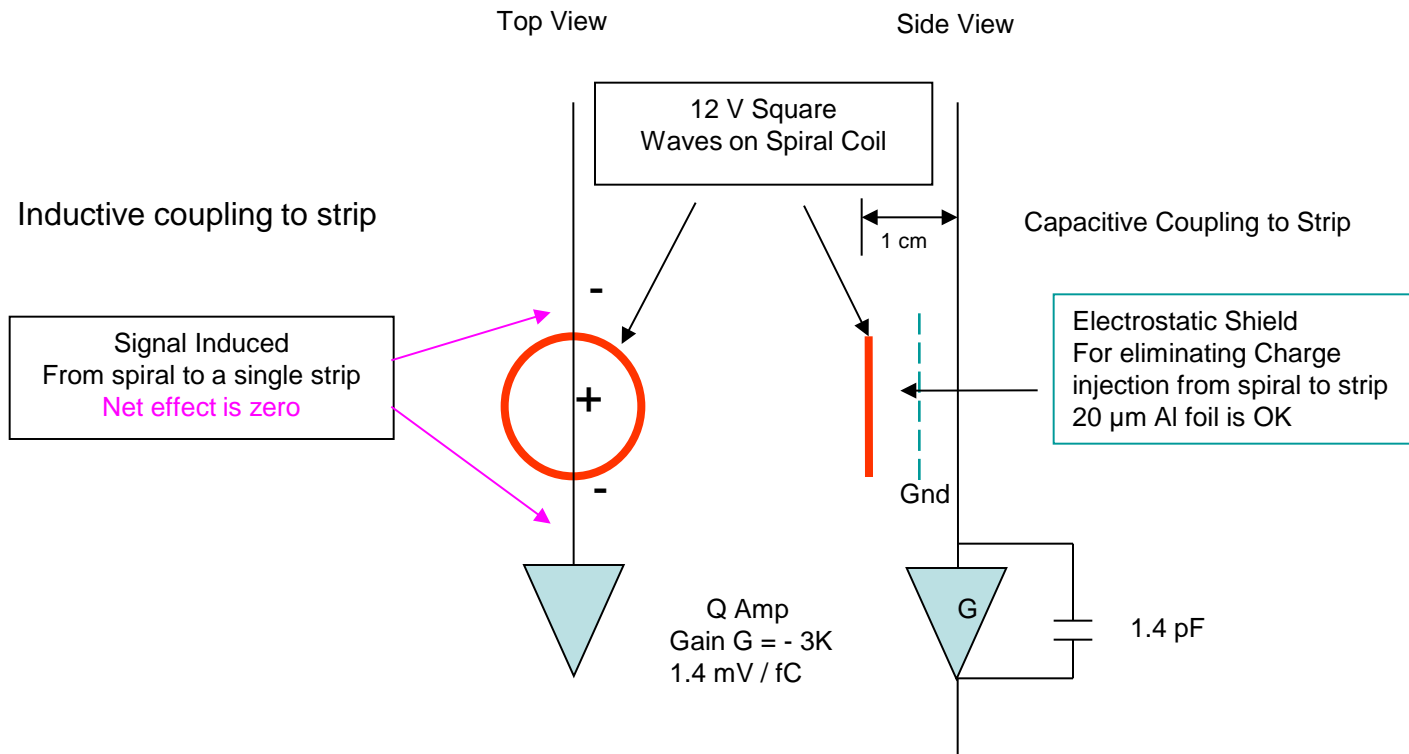


Test Silicon Strip Detector



Signal Chain





Why do we need electrostatic Shield ?

Parallel Plate Capacitance in pF = $0.225 \times A \times K / \text{Distance}$

| | Inches | C in femto farads |
|--------------------|--------|-------------------|
| Area = | 1 | |
| Distance = | 0.4 | 500 |
| GLAST = .5 x 1.3 | 0.6 | |
| per strip= 0.6 /48 | 0.0125 | 6.25 |

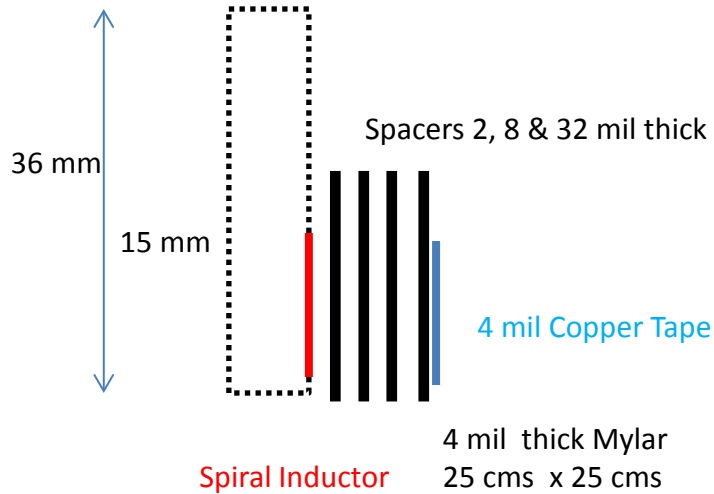
1 volt swing on spiral coil will inject $Q = 6$ femto Coulombs

Charge from one minimum ionizing particle (1 mip) = 7 femto Coulombs

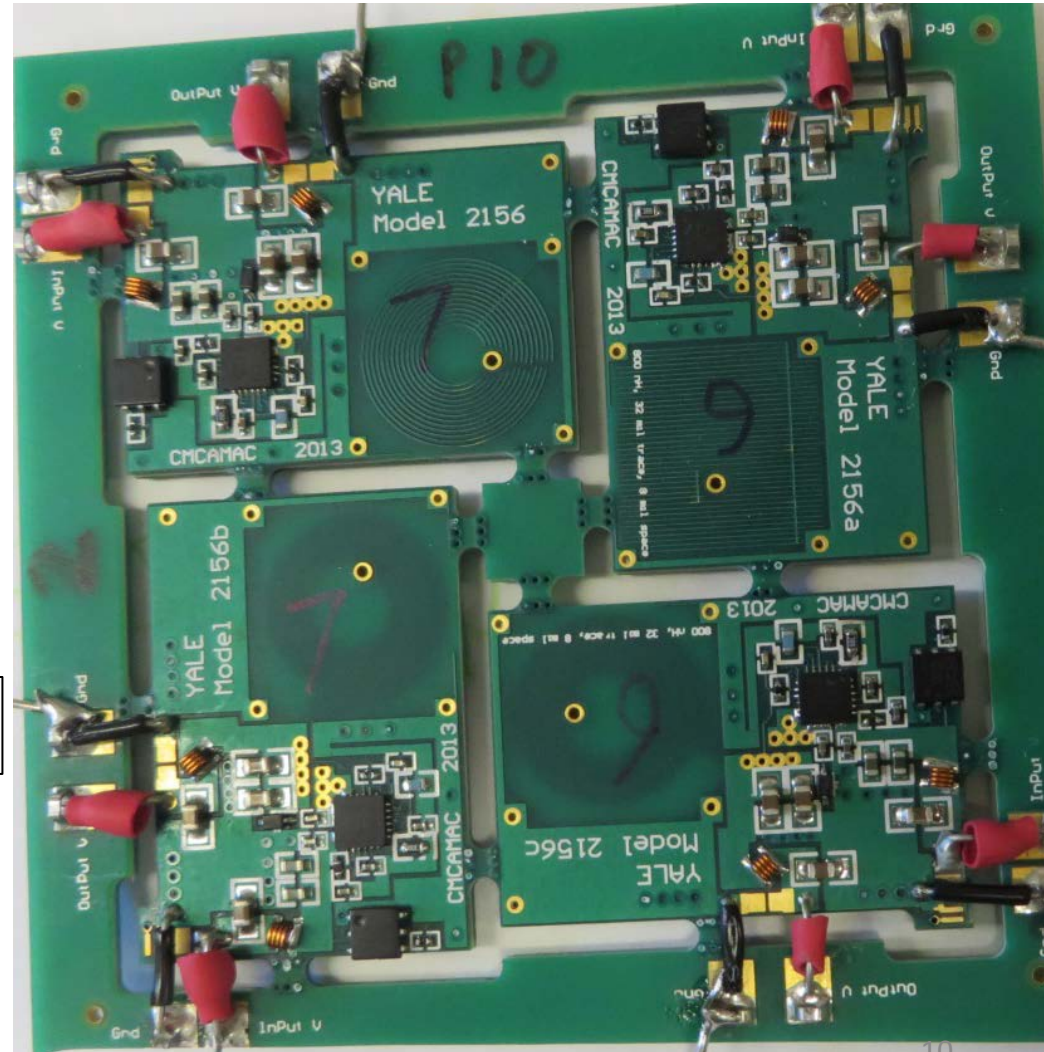
RF shielding

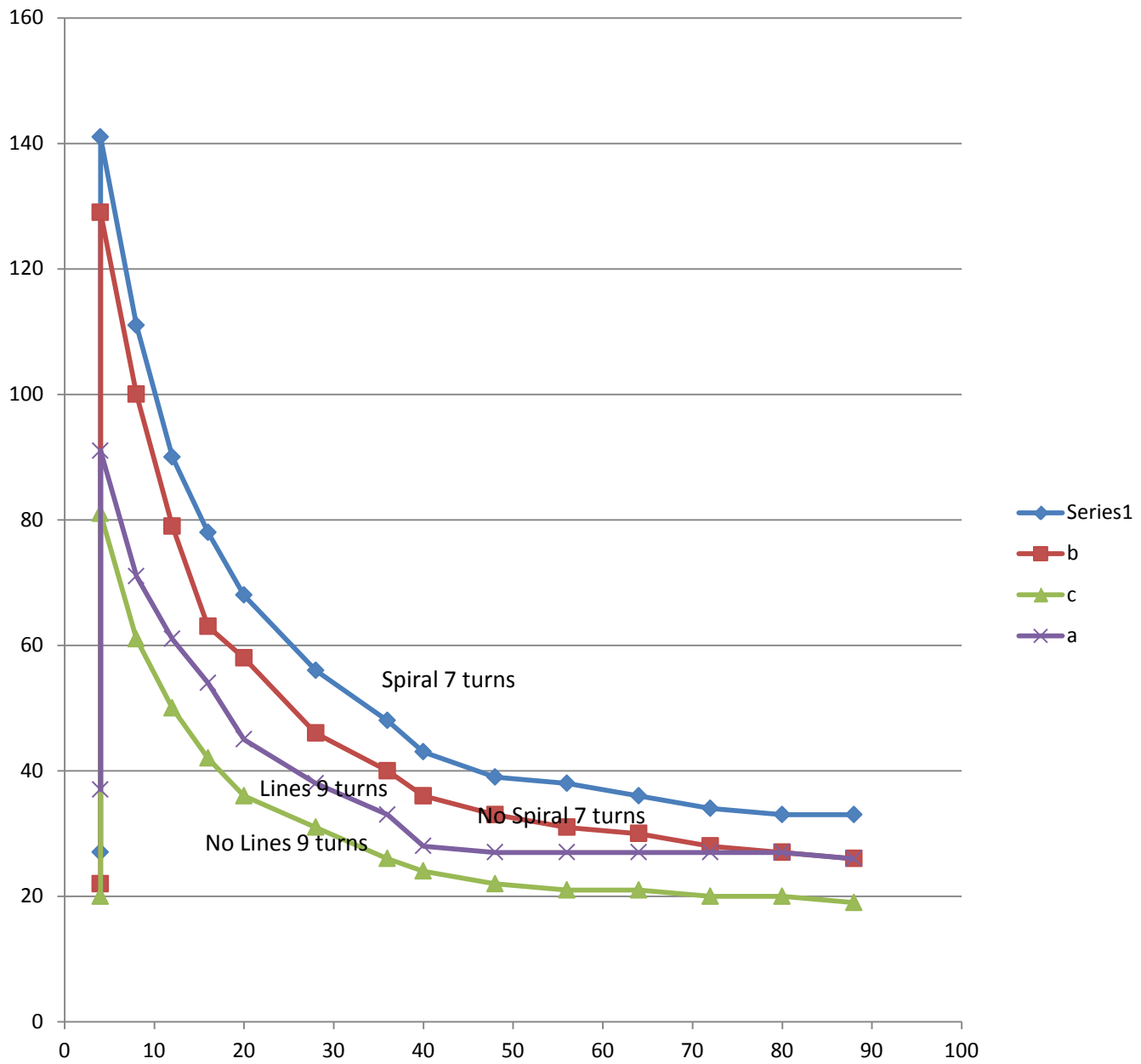
Measurement of RF field (by eddy current loss) vs distance

34 mil thick 4 layer PCB

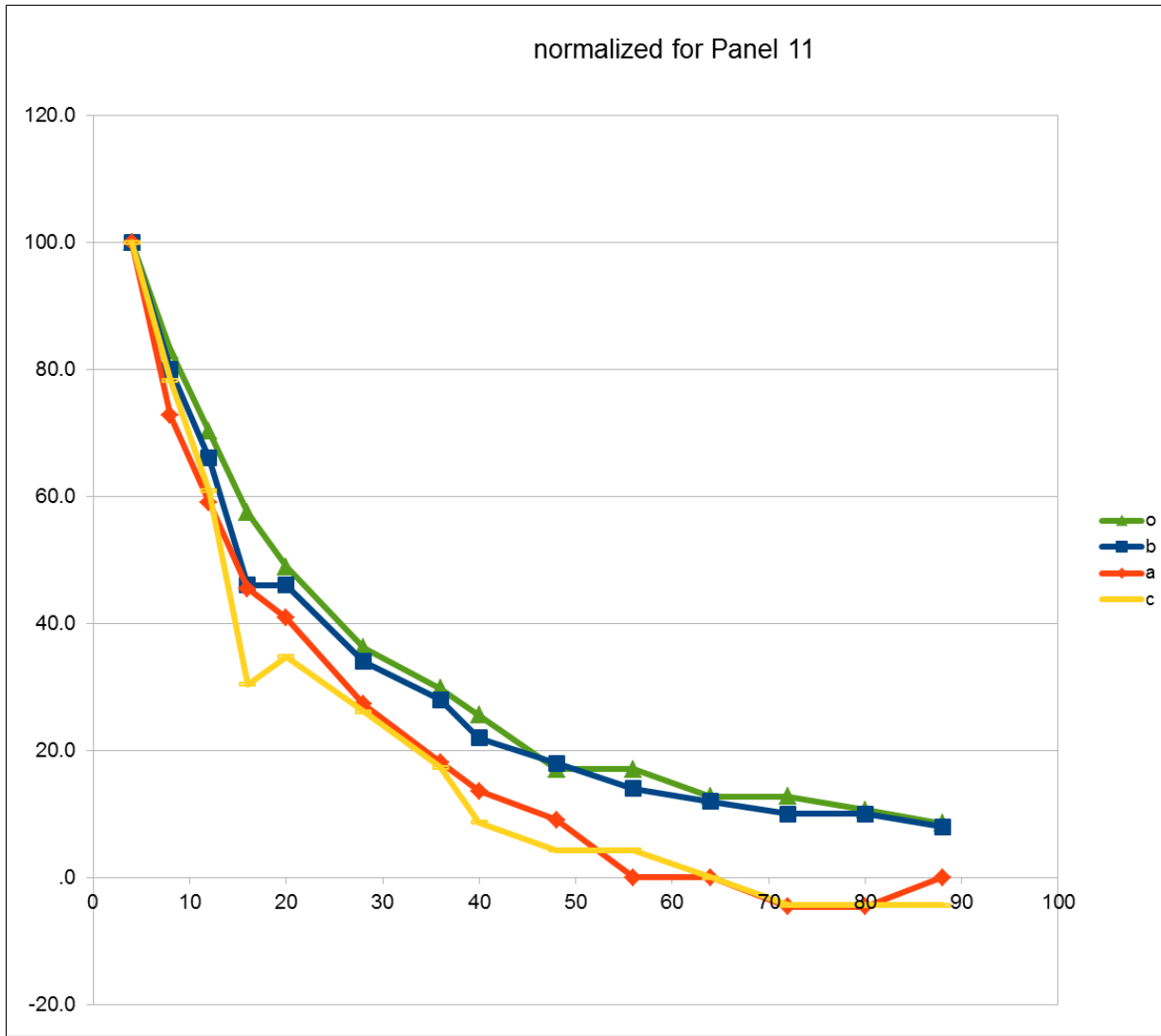


Measure IC current vs distance between spiral & copper tape
Put finger pressure between copper tape and PCB



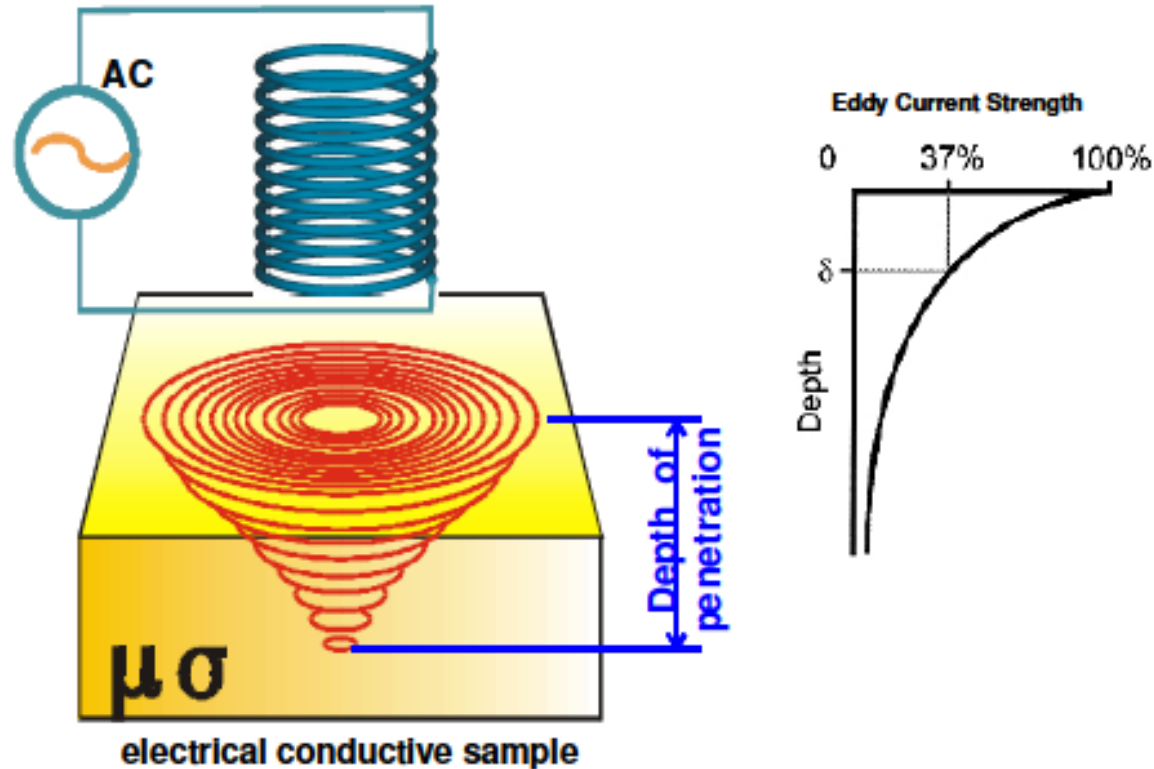


Eddy Current Loss vs Distance between Spiral to Copper Tape



Current in mA Distance in mils

Diagram 1: Eddy Current Field Depth of Penetration & Density



Skin effect arises when the Eddy Currents flowing in the test object at any depth produce magnetic fields which oppose the primary field, thus reducing the net magnetic flux and causing a decrease in current flow as the depth increases.

Alternatively, Eddy Currents near the surface can be viewed as shielding the coil's magnetic field, thereby weakening the magnetic field at greater depths and reducing induced currents.

Eddy Current is used in the inspection of ferromagnetic and non-ferromagnetic materials. The principle of Eddy Current based inspection is explained below.

Effect of the shield in the systems

Car Metal

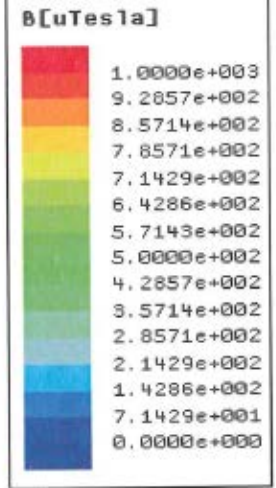
Al Plate 600 mm x 800mm 1 mm thick for mechanical strength

Coil - Top

Coil - Bottom

at t = 0sec

at 50 usec



Shields are very effective to conceal the system.

Frequency = 85 KHz

Power transmitted = 10KW

Inefficiency without Al shield = 20 %

Inefficiency with Al shield = 1 %

Power loss in Car metal without Al shield = 2 KW > 15C rise in temperature

Power loss in Al shield = 0.1 KW

Wireless Power Groups

- Automobile Charging
- Cell phone Mats - 3 Groups. Each has > 50 companies involved
- Wireless Kitchen - ISM Band 6.78 MHz & multiples. GaN

Intel 4th Generation Core Processor: June 2013

- Input = 1.8V
- Maximum Current = 700 Amps
- Output ~ 1 V Multiple Domains – up to 16 Phases
- Turn output On when needed
- Inductors on Die / on Package
- Efficiency = 90%

TABLE I. COMPARISON OF FIVR TO PREVIOUSLY REPORTED INTEGRATED VOLTAGE REGULATORS

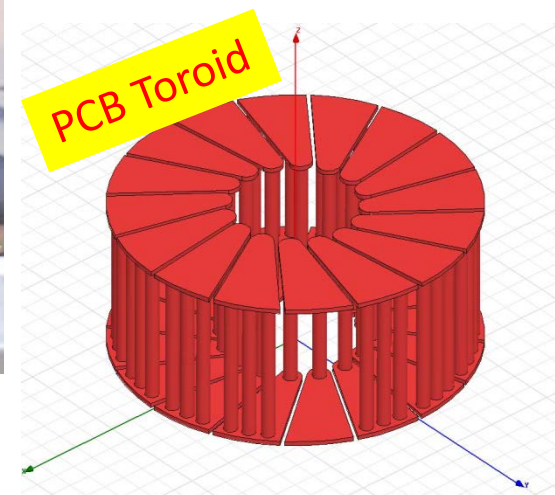
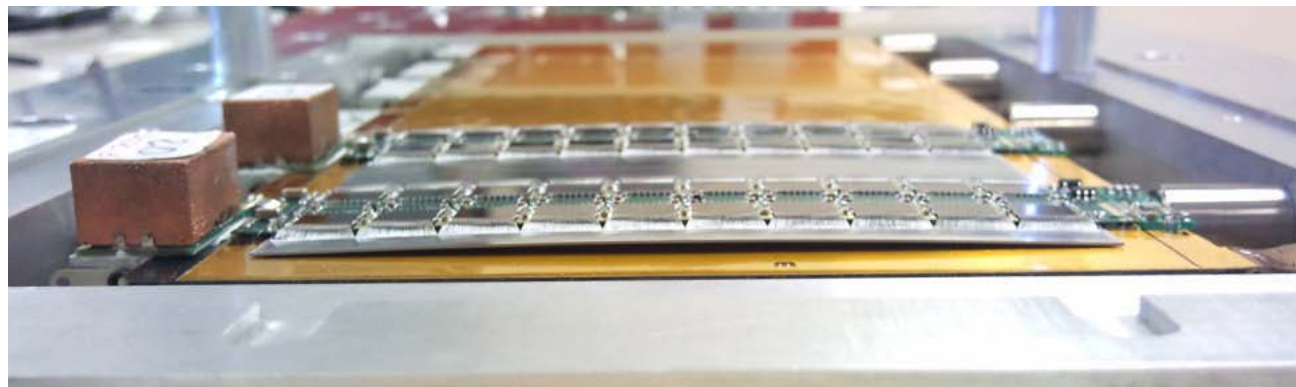
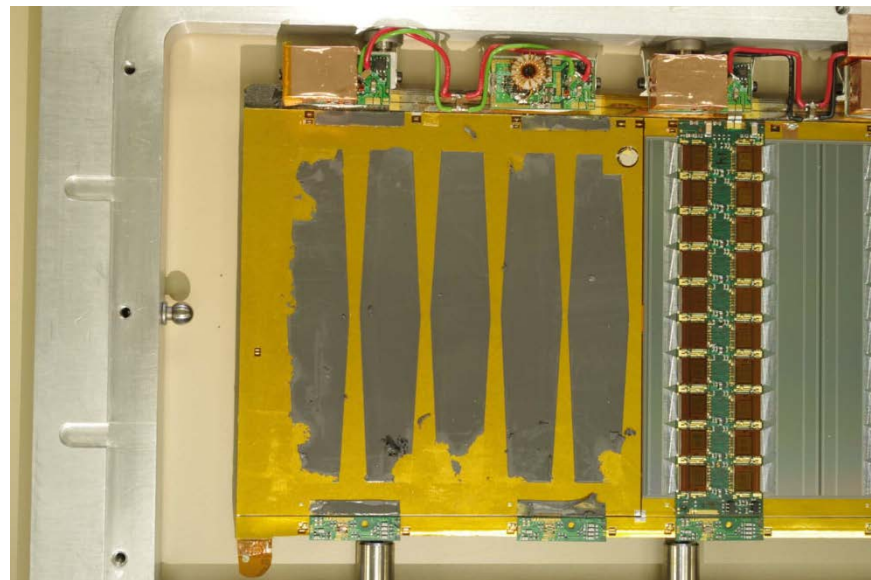
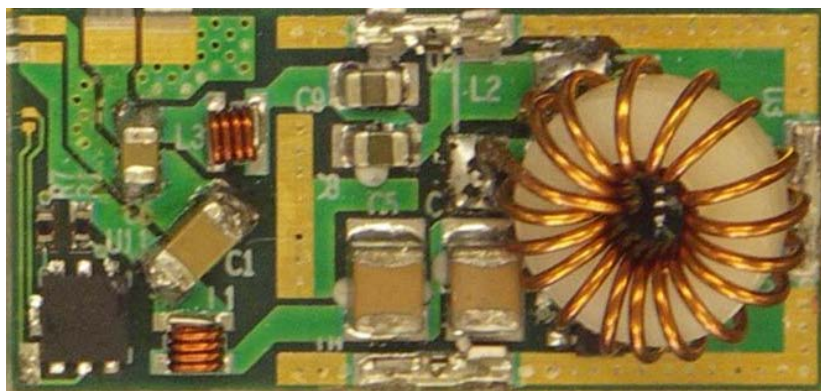
| Parameter | G. Schrom et al., 2010 [2] | T. DiBene et al., 2010 [3] | N. Sturcken et al., 2012 [4] | This Work |
|--|------------------------------------|---|------------------------------|---|
| Process node | 130 nm | 90 nm | 45 nm | 22 nm |
| Switching Frequency | 60 MHz | 100 MHz | 80 MHz | 140 MHz |
| Unity Gain Freq | 5 MHz | Not Published | Not Published | 80MHz |
| Efficiency | 85-88%, 3.3V:1.0V | 76% | 83%, 1.5V:1.0V | 90%, 1.7V:1.05V |
| Total Output I _{max} capability | 50 A | Limited by first stage and thermals (Up to 400 A) | 1.2 A | Limited by first stage and thermals (Up to 700 A) |
| I _{max} /VR die area | 1.3 A/mm ² | 8 A/mm ² | 1.7 A/mm ² | 31 A/mm ² |
| Voltage rail count | 4 | 20 | 1 | 8 to 31 |
| Phase count | 16 | 320 | 4 | 49 to 360 |
| Integration level | MCM ^a | MCM ^a | Integrated into network die | Integrated into CPU die |
| Inductor technology | Package trace, & magnetic discrete | Magnetic thin-film on VR die | Discrete wire-wound air core | 2D array of package trace |
| Capacitor type | Ceramic package caps | Ceramic package caps | Die Cap | Die Cap - MIM |
| Cout per Max Amp | 2000 nF/A | not published | 15 nF/A | 7 nF/A |

^a MCM – Multi Chip Module – the active circuitry is on a separate die assembled on the same package

Mac Pro Air !!!

ATLAS DC-DC Powered Stave

STV10 DC-DC Converter From CERN group
Based on commercial LT chip
10V in, 2.6V out, up to 5A



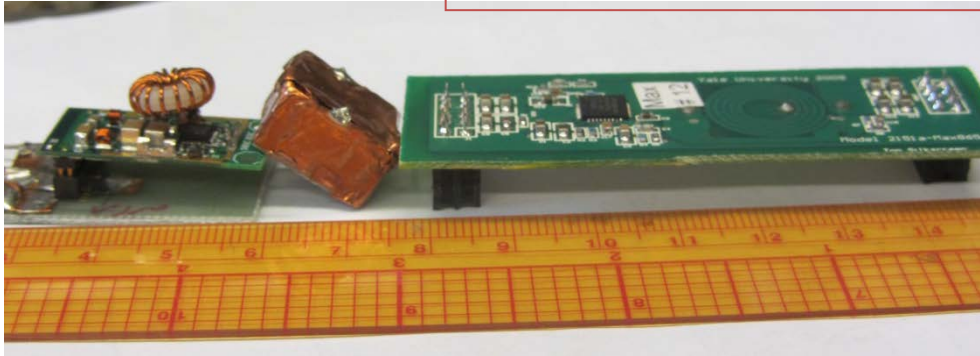
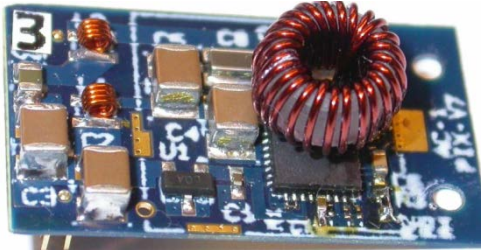
Peter W Phillips
STFC RAL
14/11/11

Last Proposal to DoE to develop Inductors

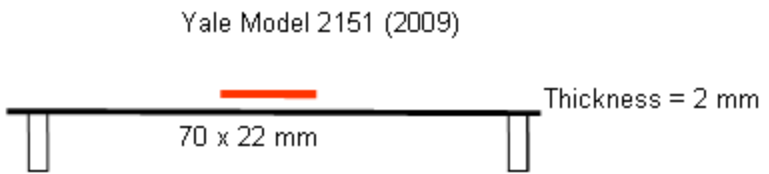
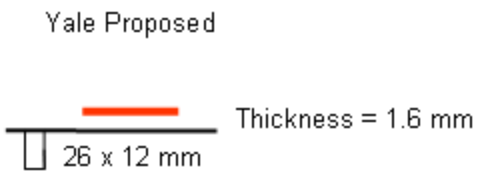
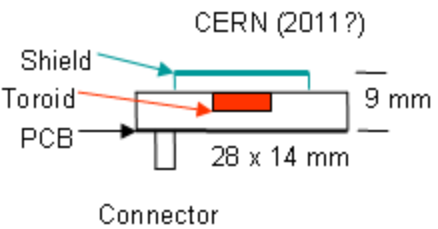
Another air core Toroid solution

An air core Toroid solution with shield

2009 Yale Solution with Embedded air core Spiral inductors in a 4 layer Standard PCB. Not shown an electrostatic 10 μm Al foil Shield



Yale version can be made same size as the Toroid solution by changing power connectors



Thickness excludes power connector

Generic / Project funding???

Planar Coil – “Up Close and Personal”

Double Trigger Noise (DTN)

With Toroid Converter

Reference measurement (CERN STV10 converter) @ 0.5fC

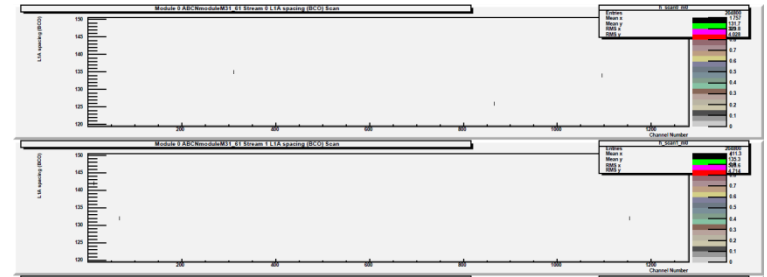


- CERN converter registers zero occupancy until 0.5fC, then registers 528/244 hits

Above picture is Double trigger noise i.e. after a hit ; spurious counts are registered

With Planar Converter

Approx <3mm from wire bonds with improved reference @ 0.5fC



- For conducted noise configuration, Planar coil registers zero occupancy (even at 0.5fC)
- Only when close to ASICs are hits registered, 3/2 counts at 0.5fC, see above

Comments inserted by Yale University

Noise in Electrons Measured @ Liverpool

cern stv10 noise 589, 604 average = 601

yale planar noise 587, 589 average = 588

noise with dc supplies (no dcdc) = 580

assuming the noise adds in quadrature, extract noise due to dcdc converter:

cern stv10 Additional noise = 157

yale planar Additional noise = 96

Planar Converter uses the same components except Inductor coil

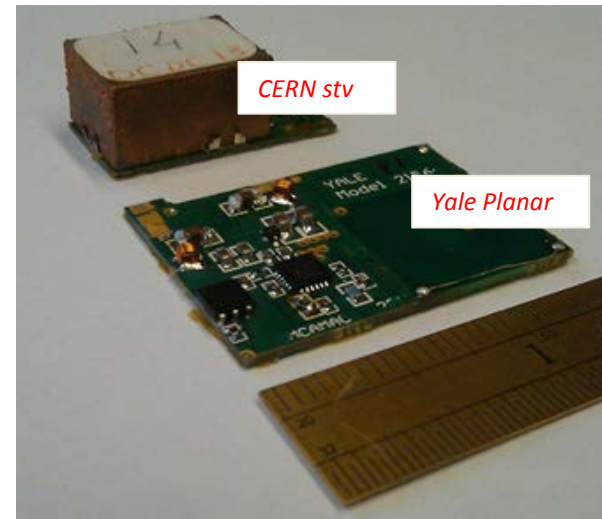
Thickness of stv = 8 mm vs 3mm for Planar

Shield to Silicon strips are Electrostatics & Eddy current

Bottom side shield 2 mm from Planar coil traces

Can be mounted on the sensor with 50 μ m Kapton

Cooling via sensor



3-Feb-14
3:30 PM

Comparison of Coils for DC-DC Converters

Yale University

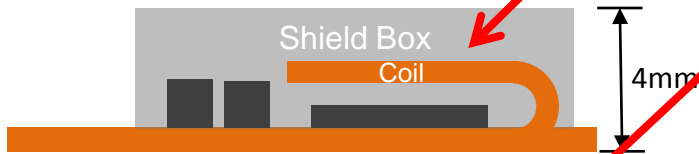
| Model | | CERN AMIS5MP Data Sheet | Yale 9 mm ID proto coil | Yale 9 mm ID proto coil | Yale 9 mm ID estimated | Yale 6 mm ID Model 2156 | Yale 6 mm ID Model 2156a |
|----------------------------------|----------|-------------------------------|-------------------------------|-------------------------------|------------------------------|-------------------------------|--------------------------------|
| coil shape | | oval toroid | 2 layer spiral | 2 layer spiral | 2 layer spiral | 2 layer spiral | 2 layer spiral |
| Total number of turns | | 29 | 8 | 6 | 6 | 7 | 9 |
| conductor | | Cu wire | Cu wire | Cu wire | Cu wire | pcb trace | pcb trace |
| equivalent wire gauge | | 25 | 22 | 22 | 25 | 28 | 29 |
| Coil dimensions | mm | 10 x 15 | 14.5 OD | 13 OD | 12 OD | 14.5 OD | 15.5 OD |
| thickness | mm | 4.00 | 1.80 | 1.80 | 1.20 | 0.50 | 0.50 |
| Inductance | nH | 430 | 836 | 469 | 469 | 487 | 811 |
| DC Resistance | mOhms | 39 | 18 | 13 | 26 | 47 | 83 |
| Weight grams | Grams | 0.537 | 0.978 | 0.702 | 0.360 | 0.203 | 0.220 |
| Length of Wire | mm | 370 | 336 | 240 | 240 | 221.000 | 307.000 |
| Power Loss in Coil @ 4 Amps | Watts | 0.608 | 0.288 | 0.208 | 0.416 | 0.752 | 1.328 |
| normalized weight | | 1.00 | 1.82 | 1.31 | 0.67 | 0.38 | 0.41 |
| normalized power loss | | 1.00 | 0.47 | 0.34 | 0.68 | 1.24 | 2.18 |
| DC DC ripple current in inductor | RMS Amps | 0.657 | 0.340 | 0.602 | 0.602 | 0.580 | 0.348 |

Note: the Inductor ripple current produces the AC magnetic field, which must be shielded from the sensors

Proposed Thinner Converter: Coil

No magnetic materials

PCB size = 8 mm x 26 mm



Question on Air Core Coil (change to oval shape as width is limited)

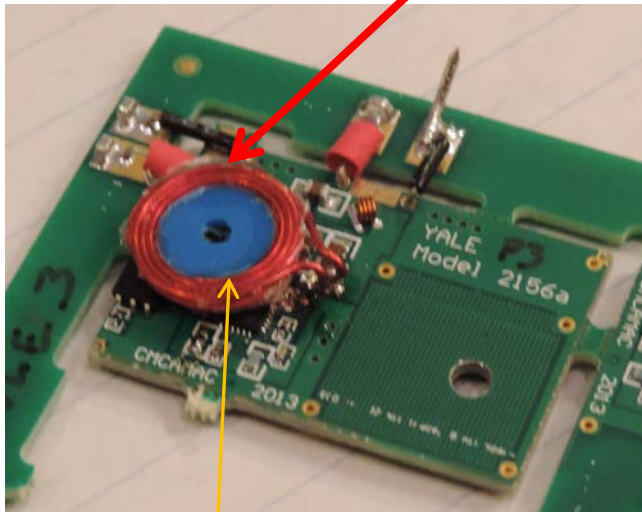
Take this coil and squeeze/ stretch it to 8 mm x 26 mm.
wire size 24 - 28 AWG Frequency 2 MHz; Later 10 MHz

$L = 800 \text{ nH}$

Losses are limited by DCR and not ACR.

of turns = ?

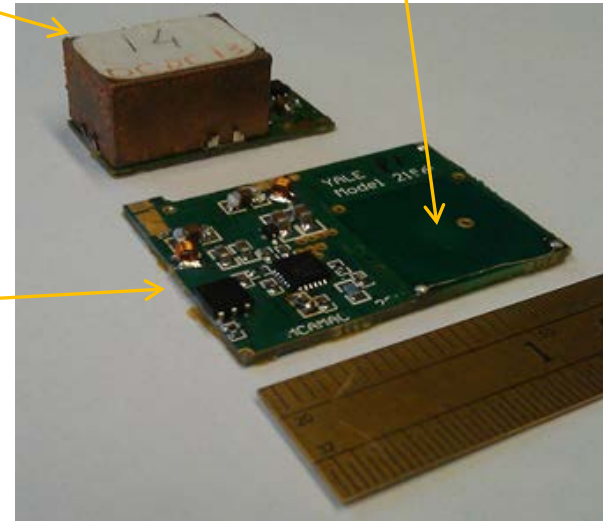
ACR & DCR with wire Gauge



Toroid Inductor with Shield on toroid
height = 8 mm

Embedded Spirals

Disabled for the hand wound coil
Height = 2 mm plus shield



Yale Model 2156a

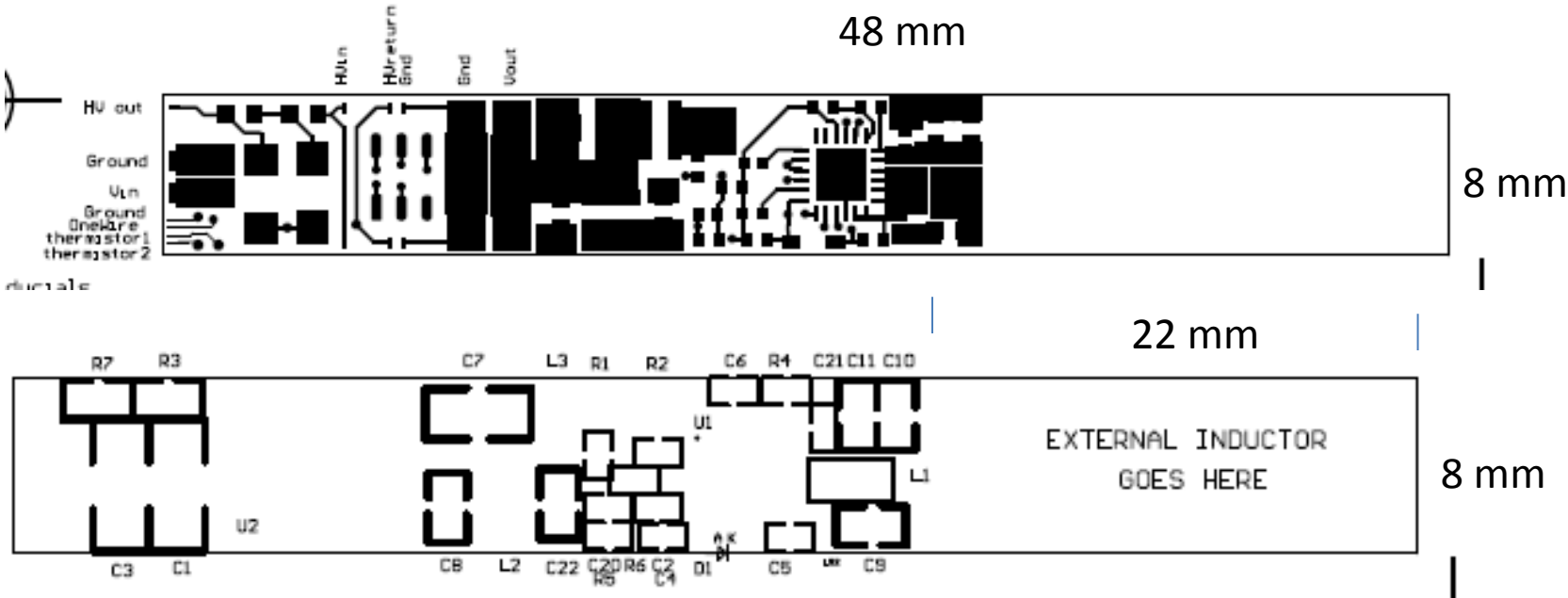
PCB size 24mm x 36 mm

Coil size 16 mm dia. Embedded in 4 layer PCB. Inner 2 layer spirals are in series is the inductor.

2 versions: Total 6 or 9 turns

Hand wound coil (Short solenoid) is 24 AWG. Lower DCR for same inductance

Work in Progress



Coil to fit in 8 mm x 22mm
Embed in PCB?



Winding Frame
8 mm x 22 mm
Slot in middle to hold wire

AWG 24

g-2 Ribbon 9 mils x 90 mils

5 turns. Inductance = 715 nH
DCR = <100 mΩ

Lower Inductance

- ❖ 2 turns vs 5 turns
- ❖ Higher Ripple current
- ❖ Shield distance is higher
- ❖ More lost power in shield

Simulations

s. Kalani UCL; UK Atlas Group

We want to understand the efficiency costs of the external shield for the planar coils.

For a given planar coil we would like a plot of the energy loss in the shields as a function of distance from the coil. There should be a shield on each side of the coil placed symmetrically. The inductance of the coil changes as the distance to the shields changes. Since the ripple current is inversely proportional to the inductance this must be included in the calculation.

I expect that the energy loss in the shield will be linearly proportional to the ripple current but we should check this by simulating two different ripple currents for the same configuration.

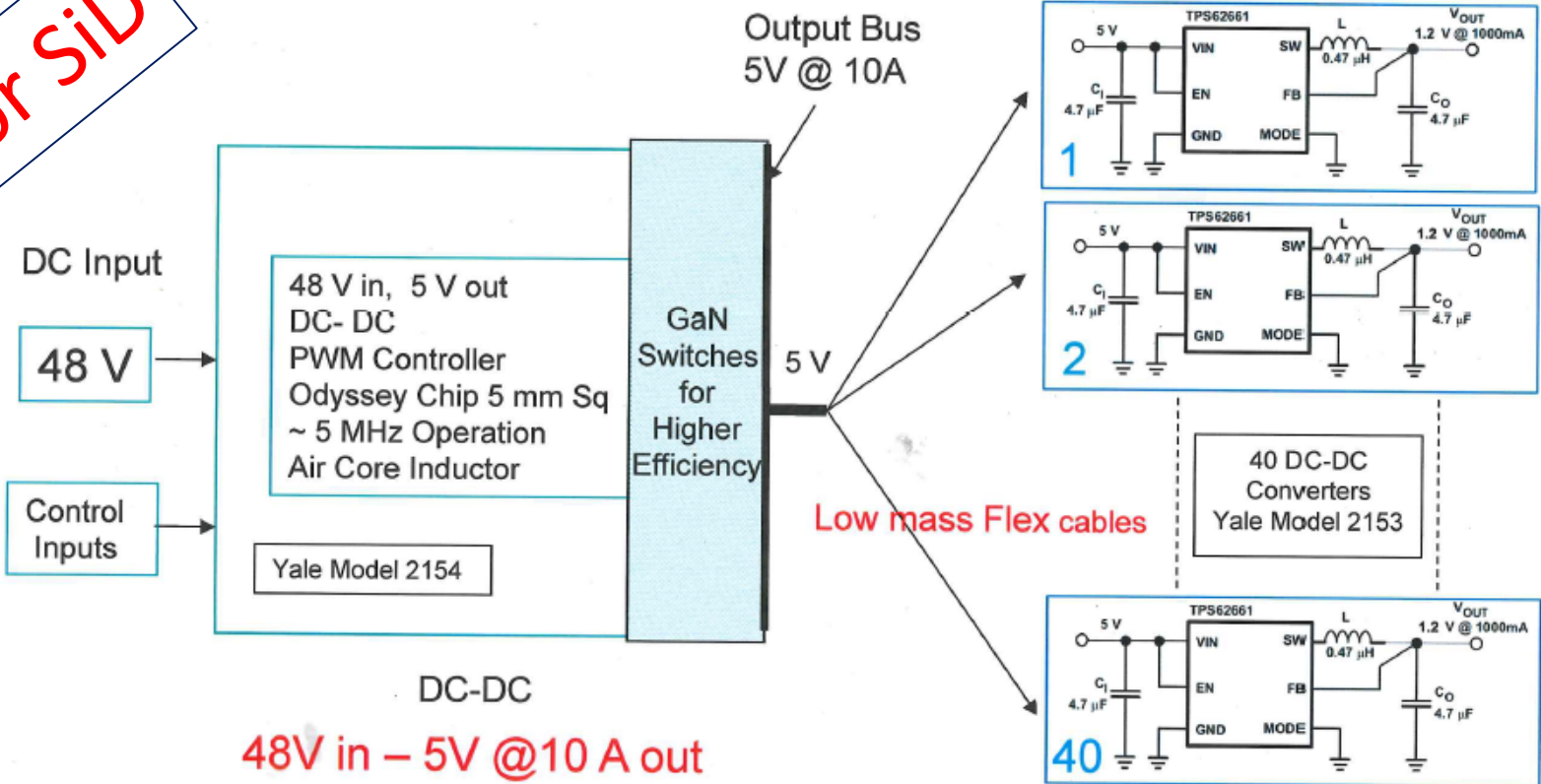
For each coil configuration we would like to plots, inductance and energy loss over a range of shield distances from 0.5 mm to 10 mm with appropriate step sizes. The energy loss plot should be for 1 amp at the 10 mm spacing, with the current increasing as the inductance decreases. The frequency should be 2 MHz. Use five mill thick copper for the shields.

Start with the standard nine turn two layer coil and see how it goes. After that we will want to try other coil configurations and possibly other shield thickness and material.

Two Stage DC-DC Power Conversion & Distribution



For SiD



FE Chips

FE Chips

130 nm front end chips

FE Chips

48V in – 5V @10 A out

Fewer of these modules further from the detector/sensors

Status

Model 2153: Prototype for coil configurations under Test
Model 2153: Odyssey Chip Eval Board under NDA

5V in – 1.2V @1 A out

Many of these modules close to the detector/sensors
Low mass chip scale package
small Air Core Inductor.
Test 6, 9 and 20 MHz Converters

High Frequency
Input = 5 V

Semtech SC220: 20 MHz 0.6 Amps:
North / South Coils for far Field cancellation
DCR becomes a problem

Enpirion EL711: 18 MHz 0.6 Amps



GaN Update

- ❖ 600 Volt is the holy grail
- ❖ EPC is the only one delivering Devices thru distribution
- ❖ LM5113: driver for eGaN
- ❖ 1Q2015: Half bridge. (2LM5113 + FETS) in 6 mmx 5mm x 1.5mm. 5 -10 MHz
External PWM
- ❖ GaN driver on FET Die Several companies. Panasonic Roadmap 2016

For GaN NDA

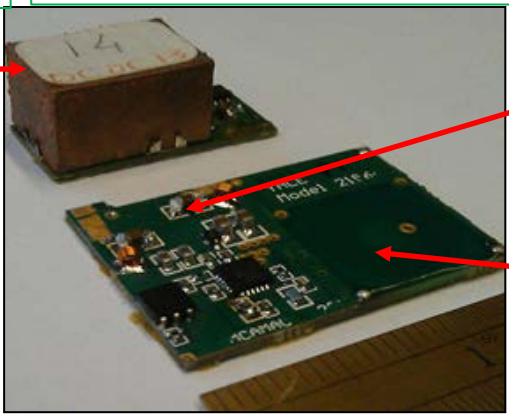
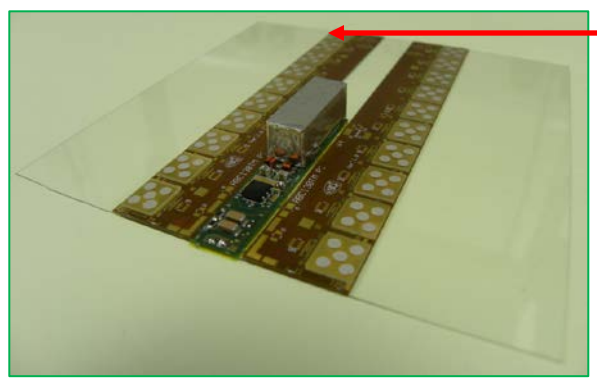
Why Yale design needs GaN

- **No magnetic materials** – All instruments in 4 Tesla magnetic field
- Design Goal = Size of converter 8 mm x 26 mm x 4 mm thickness including eddy current shield
- $V_{in} = 12\text{ V}$; $V_{out} = 2.5\text{ V} / 1.5\text{ V}$; $I_{out} = 3\text{ Amps}$ Frequency = 2 MHz
- Toroid leak H fields: Spiral /Planar 2 layer 9 turn > Inductance = 800 nH
- Need Low DCR & Lower mass to reduce noise created by protons passing thru inactive material
- Lower ripple current limits H field range > thinner package
- Why GaN ? High frequency > smaller inductor & passives. Smaller foot print

Current Design / Status

CERN design size is ok but thickness = 9 mm

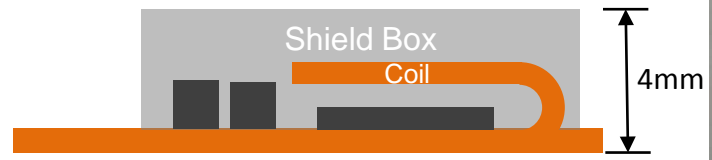
Yale design thickness is ok. Foot print Ok for circuit only but no room for inductor



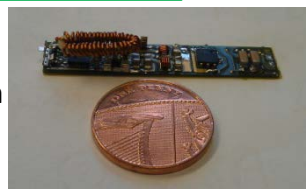
Size of PCB = 23 mm x 35 mm x 1.5 mm plus shield

Spiral inductor embedded in 4 layer PCB. Spirals are 15 mm dia.

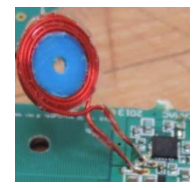
New Design



Fold Coil > Squeeze 2 layer spiral to oval shape



Oval Aircore Toroid



Short Solenoid > Low DCR

What GaN Buys us
 Higher operating frequency
 > smaller air core inductor & lower DCR
 Higher efficiency > Lower heat loss
 Smaller package *PowerSoC technology*

Closing Remarks

- ❖ 48 V into Detector: 2 Stages
- ❖ IC 2 step: 12 V > 1.2V High efficiency
- ❖ GaN: Driver on Die may be Rad Tolerant
- ❖ Need lower power loss in detector